SPI35N10 SPP35N10,SPB35N10

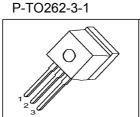
# SIPMOS® Power-Transistor

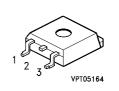
#### **Feature**

- N-Channel
- Enhancement mode
- 175°C operating temperature
- Avalanche rated
- dv/dt rated

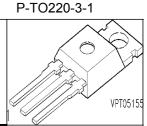
# Product Summary

$V_{DS}$	100	<b>&gt;</b>
R <sub>DS(on)</sub>	45	mΩ
I <sub>D</sub>	35	Α

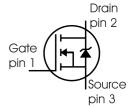




P-TO263-3-2



Туре	Package	Ordering Code	Marking
SPP35N10	P-TO220-3-1	-	35N10
SPB35N10	P-TO263-3-2	-	35N10
SPI35N10	P-TO262-3-1	-	35N10



# **Maximum Ratings**,at $T_i$ = 25 °C, unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current	$I_{D}$		Α
<i>T</i> <sub>C</sub> =25°C		35	
<i>T</i> <sub>C</sub> =100°C		-	
Pulsed drain current	I <sub>D puls</sub>	140	
<i>T</i> <sub>C</sub> =25°C			
Avalanche energy, single pulse	E <sub>AS</sub>	245	mJ
$I_{\rm D}$ =35 A , $V_{\rm DD}$ =25V, $R_{\rm GS}$ =25 $\Omega$			
Reverse diode dv/dt	d <i>v</i> /d <i>t</i>	6	kV/µs
$I_{\rm S}$ =35A, $V_{\rm DS}$ =80V, d <i>i</i> /d <i>t</i> =200A/ $\mu$ s, $T_{\rm jmax}$ =175°C			
Gate source voltage	$V_{\mathrm{GS}}$	±20	V
Power dissipation	P <sub>tot</sub>	150	W
<i>T</i> <sub>C</sub> =25°C			
Operating and storage temperature	$T_{\rm j}$ , $T_{ m stg}$	-55 +175	°C
IEC climatic category; DIN IEC 68-1		55/175/56	



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#### **Thermal Characteristics**

Parameter	Symbol	Values		Unit	
		min.	typ.	max.	
Characteristics	,		,		
Thermal resistance, junction - case	$R_{\mathrm{thJC}}$	-	-	1	K/W
Thermal resistance, junction - ambient, leaded	$R_{thJA}$	-	-	100	
SMD version, device on PCB:	R <sub>thJA</sub>				
@ min. footprint		-	-	75	
@ 6 cm <sup>2</sup> cooling area <sup>1)</sup>		-	-	50	

### **Electrical Characteristics**, at $T_i$ = 25 °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Static Characteristics					
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	100	-	_	V
$V_{GS} = 0V, I_D = 1mA$					
Gate threshold voltage, $V_{GS} = V_{DS}$	V <sub>GS(th)</sub>	2.1	3	4	
<i>I</i> <sub>D</sub> = 83 μA					
Zero gate voltage drain current	I <sub>DSS</sub>				μA
$V_{\rm DS}$ =100V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =25°C		-	0.01	1	
$V_{\rm DS}$ =100V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =125°C		-	1	100	
Gate-source leakage current	$I_{GSS}$	-	1	100	nA
V <sub>GS</sub> =20V, V <sub>DS</sub> =0V					
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	tbd	45	mΩ
V <sub>GS</sub> =10V, I <sub>D</sub> =-A					

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 $<sup>^{1}</sup>$ Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical without blown air.



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<b>Electrical Characteristics</b> , at $T_j = 25$ °C, unless otherwise specified						
Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic Characteristics						,
Transconductance	g <sub>fs</sub>	$V_{\text{DS}} \ge 2^* I_{\text{D}}^* R_{\text{DS(on)max}}$ ,	tbd	tbd	-	S
		<i>I</i> <sub>D</sub> =-A				
Input capacitance	C <sub>iss</sub>	$V_{GS}$ =0V, $V_{DS}$ =25V,	_	tbd	tbd	pF
Output capacitance	Coss	<i>f</i> =1MHz	_	tbd	tbd	
Reverse transfer capacitance	$C_{rss}$		_	tbd	tbd	
Turn-on delay time	$t_{d(on)}$	V <sub>DD</sub> =50V, V <sub>GS</sub> =10V,	-	tbd	tbd	ns
Rise time	$t_{r}$	$I_{\rm D}$ =35A, $R_{\rm G}$ =7 $\Omega$	-	tbd	tbd	
Turn-off delay time	t <sub>d(off)</sub>		-	tbd	tbd	
Fall time	$t_{f}$		-	tbd	tbd	
Gate Charge Characteristics	,	,	•			•
Gate to source charge	Q <sub>gs</sub>	V <sub>DD</sub> =80V, I <sub>D</sub> =35A	-	tbd	tbd	nC
Gate to drain charge	Q <sub>gd</sub>		-	tbd	tbd	]
Gate charge total	$Q_g$	V <sub>DD</sub> =80V, I <sub>D</sub> =35A,	-	tbd	tbd	
		V <sub>GS</sub> =0 to 10V				
Gate plateau voltage	V <sub>(plateau)</sub>	V <sub>DD</sub> =80V, I <sub>D</sub> =35A	-	tbd	-	V
Reverse Diode			•		•	•
Inverse diode continuous	Is	T <sub>C</sub> =25°C	-	-	35	Α
forward current						
Inverse diode direct current,	/ <sub>SM</sub>		-	-	140	1
pulsed						
Inverse diode forward voltage	$V_{\mathrm{SD}}$	V <sub>GS</sub> =0V, I <sub>F</sub> =35A	-	tbd	tbd	V
Reverse recovery time	t <sub>rr</sub>	V <sub>R</sub> =50V, I <sub>F</sub> =I <sub>S</sub> ,	-	tbd	tbd	ns
Reverse recovery charge	Q <sub>rr</sub>	d <i>i</i> <sub>F</sub> /d <i>t</i> =100Α/μs	-	tbd	tbd	nC

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